

Notice of References Cited	Application/Control No. 10/021,434	Applicant(s)/Patent Under Reexamination YOKOO ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	DE 3726487	12-1987	Germany	Buchhem et al	---
	O	JP 11009190	01-1999	Japan	Muramot et al	---
	P					
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NON-PATENT DOCUMENTS

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